# **N-Channel Power MOSFET 500 V, 0.52** Ω

#### **Features**

- Low ON Resistance
- Low Gate Charge
- ESD Diode-Protected Gate
- 100% Avalanche Tested
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

# **ABSOLUTE MAXIMUM RATINGS** ( $T_C = 25^{\circ}C$ unless otherwise noted)

Rating	Symbol	NDF	Unit
Drain-to-Source Voltage	$V_{DSS}$	500	V
Continuous Drain Current, R <sub>0</sub> JC (Note 1)	I <sub>D</sub>	12	Α
Continuous Drain Current $T_A = 100$ °C, $R_{\theta JC}$ (Note 1)	I <sub>D</sub>	7.4	А
Pulsed Drain Current, t <sub>P</sub> = 10 μs	I <sub>DM</sub>	44	А
Power Dissipation, $R_{\theta JC}$	P <sub>D</sub>	39	W
Gate-to-Source Voltage	$V_{GS}$	±30	V
Single Pulse Avalanche Energy, I <sub>D</sub> = 10 A	E <sub>AS</sub>	420	mJ
ESD (HBM) (JESD22-A114)	V <sub>esd</sub>	4000	V
RMS Isolation Voltage (t = 0.3 sec., R.H. $\leq$ 30%, T <sub>A</sub> = 25°C) (Figure 14)	V <sub>ISO</sub>	4500	V
Peak Diode Recovery (Note 2)	dv/dt	4.5	V/ns
MOSFET dV/dt	dV/dt	60	V/ns
Continuous Source Current (Body Diode)	I <sub>S</sub>	12	А
Maximum Temperature for Soldering Leads	T <sub>L</sub>	260	°C
Operating Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	-55 to 150	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

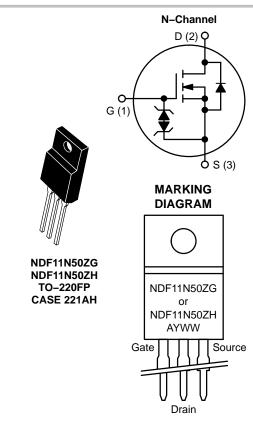
- 1. Limited by maximum junction temperature 2.  $I_d \le 10.5 \text{ A}$ ,  $di/dt \le 200 \text{ A/µs}$ ,  $V_{DD} \le BV_{DSS}$ ,  $T_J \le 150^{\circ}\text{C}$ .



# ON Semiconductor®

### www.onsemi.com

V <sub>DSS</sub>	R <sub>DS(ON)</sub> (MAX) @ 4.5 A
500 V	0.52 Ω



= Location Code

= Year

WW = Work Week

G, H = Pb-Free, Halogen-Free Package

### **ORDERING INFORMATION**

See detailed ordering and shipping information on page 6 of this data sheet.

### THERMAL RESISTANCE

Parameter	Symbol	NDF11N50Z	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	3.2	°C/W
Junction-to-Ambient Steady State (Note 3)	$R_{\theta JA}$	50	

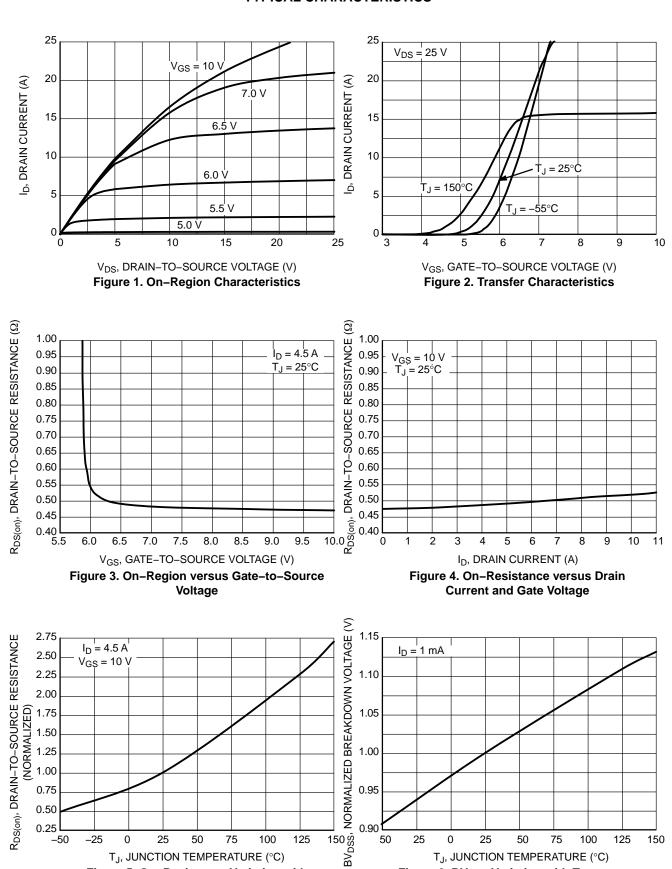
# FLECTRICAL CHARACTERISTICS (T. = 25°C unless otherwise noted)

Characteristic	Test Conditions		Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTICS					•	•	•
Drain-to-Source Breakdown Voltage	$V_{GS} = 0 \text{ V, } I_{D} = 1 \text{ mA}$		BV <sub>DSS</sub>	500			V
Breakdown Voltage Temperature Coefficient	Reference to 25°C, I <sub>D</sub> = 1 mA		$\Delta BV_{DSS}/ \Delta T_{J}$		0.6		V/°C
Drain-to-Source Leakage Current	V 500 V V 0 V	25°C	I <sub>DSS</sub>			1	μΑ
	$V_{DS} = 500 \text{ V}, V_{GS} = 0 \text{ V}$	125°C				50	
Gate-to-Source Forward Leakage	V <sub>GS</sub> = ±20 V		I <sub>GSS</sub>			±10	μΑ
ON CHARACTERISTICS (Note 4)					•	•	
Static Drain-to-Source On-Resistance	$V_{GS} = 10 \text{ V}, I_D = 4.5 \text{ A}$	A	R <sub>DS(on)</sub>		0.48	0.52	Ω
Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 100 \mu$	A	V <sub>GS(th)</sub>	3.0	3.9	4.5	V
Forward Transconductance	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 4.5 A		9FS		7.7		S
YNAMIC CHARACTERISTICS							
Input Capacitance (Note 5)	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1.0 MHz		C <sub>iss</sub>	1097	1375	1645	pF
Output Capacitance (Note 5)			C <sub>oss</sub>	132	166	199	
Reverse Transfer Capacitance (Note 5)			C <sub>rss</sub>	30	40	50	
Total Gate Charge (Note 5)			Qg	23	46	69	nC
Gate-to-Source Charge (Note 5)	V 050 V I 40 5		Q <sub>gs</sub>	4.5	8.7	13	1
Gate-to-Drain ("Miller") Charge (Note 5)	$V_{DD} = 250 \text{ V, } I_D = 10.5$ $V_{GS} = 10 \text{ V}$	$V_{DD} = 250 \text{ V}, I_D = 10.5 \text{ A},$ $V_{GS} = 10 \text{ V}$		12.5	25	37.5	
Plateau Voltage			V <sub>GP</sub>		6.2		V
Gate Resistance			R <sub>g</sub>		1.4		Ω
ESISTIVE SWITCHING CHARACTERI	STICS		•			•	•
Turn-On Delay Time			t <sub>d(on)</sub>		15		ns
Rise Time	V <sub>DD</sub> = 250 V, I <sub>D</sub> = 10.5	A,	t <sub>r</sub>		32		
Turn-Off Delay Time	$V_{GS} = 10 \text{ V}, R_G = 5 \Omega$		t <sub>d(off)</sub>		40		
Fall Time			t <sub>f</sub>		23		1
OURCE-DRAIN DIODE CHARACTER	ISTICS (T <sub>C</sub> = 25°C unless other	erwise not	ed)		-	-	-
Diode Forward Voltage	I <sub>S</sub> = 10.5 A, V <sub>GS</sub> = 0 \		V <sub>SD</sub>			1.6	V
Reverse Recovery Time	V <sub>GS</sub> = 0 V, V <sub>DD</sub> = 30 \	/	t <sub>rr</sub>		310		ns
Reverse Recovery Charge	$I_S = 10.5 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}$		Q <sub>rr</sub>		2.5		μС

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

- 3. Insertion mounted
  4. Pulse Width ≤ 380 μs, Duty Cycle ≤ 2%.
- 5. Guaranteed by design.

#### TYPICAL CHARACTERISTICS



T<sub>J</sub>, JUNCTION TEMPERATURE (°C)

Figure 6. BV<sub>DSS</sub> Variation with Temperature

T<sub>J</sub>, JUNCTION TEMPERATURE (°C)

Figure 5. On-Resistance Variation with

**Temperature** 

## **TYPICAL CHARACTERISTICS**

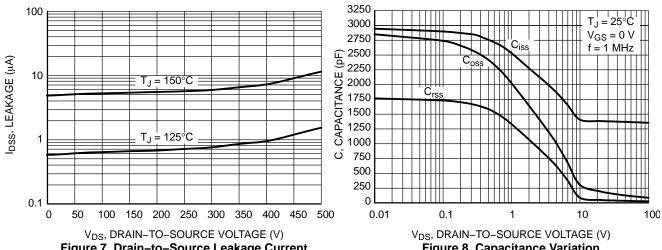
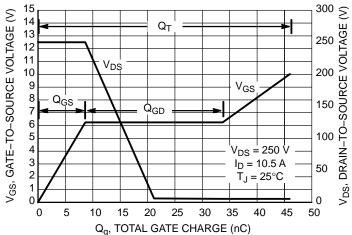


Figure 7. Drain-to-Source Leakage Current versus Voltage

Figure 8. Capacitance Variation



 ${\bf Q}_g,$  TOTAL GATE CHARGE (nC) Figure 9. Gate–to–Source Voltage and Drain-to-Source Voltage versus Total Charge

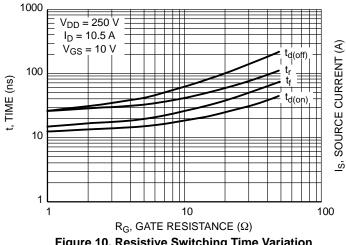


Figure 10. Resistive Switching Time Variation versus Gate Resistance

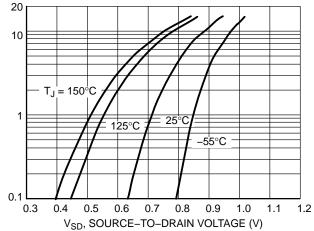


Figure 11. Diode Forward Voltage versus Current

### **TYPICAL CHARACTERISTICS**

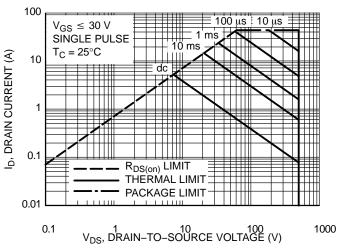


Figure 12. Maximum Rated Forward Biased Safe Operating Area NDF11N50Z

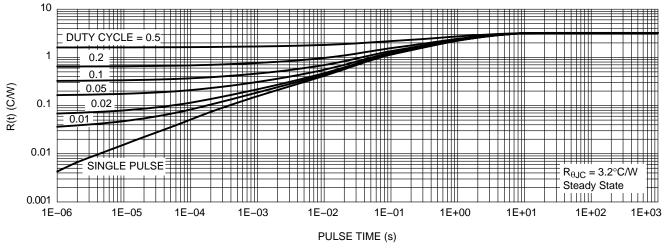


Figure 13. Thermal Impedance (Junction-to-Case) for NDF11N50Z

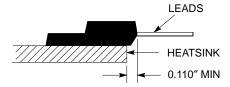


Figure 14. Isolation Test Diagram

Measurement made between leads and heatsink with all leads shorted together.

\*For additional mounting information, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

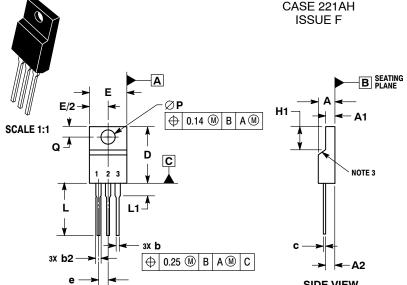
# ORDERING INFORMATION

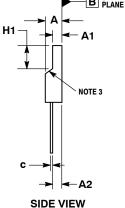
Order Number	Package	Shipping	
NDF11N50ZG	TO-220FP (Pb-Free, Halogen-Free)	50 Units / Rail	
NDF11N50ZH	TO-220FP (Pb-Free, Halogen-Free)	50 Units / Rail	



CASE 221AH

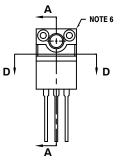
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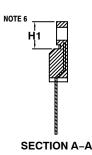






**FRONT VIEW** 





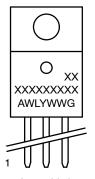
**ALTERNATE CONSTRUCTION** 

#### NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- 2. CONTROLLING DIMENSION: MILLIMETERS.
  3. CONTOUR UNCONTROLLED IN THIS AREA.
- CONTOUR ONCOUNT HOLLED IN THIS AREA.
   DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH AND GATE PROTRUSIONS. MOLD FLASH AND GATE PROTRUSIONS NOT TO EXCEED 0.13 PER SIDE. THESE DIMENSIONS ARE TO BE MEASURED AT OUTERMOST EXTREME OF THE PLASTIC BODY.
   DIMENSION b2 DOES NOT INCLUDE DAMBAR PROTRUSION.
   LEAD WIDTH INCLUDING PROTRUSION SHALL NOT EXCEED 2.00.
- 6. CONTOURS AND FEATURES OF THE MOLDED PACKAGE BODY MAY VARY WITHIN THE ENVELOP DEFINED BY DIMENSIONS AT AND H1 FOR MANUFACTURING PURPOSES.

	MILLIMETERS		
DIM	MIN	MAX	
Α	4.30	4.70	
A1	2.50	2.90	
A2	2.50	2.90	
b	0.54	0.84	
b2	1.10	1.40	
С	0.49	0.79	
D	14.70	15.30	
E	9.70	10.30	
е	2.54	BSC	
H1	6.60	7.10	
L	12.50	14.73	
L1		2.80	
P	3.00	3.40	
Q	2.80	3.20	

## **GENERIC MARKING DIAGRAM\***



= Assembly Location

WL = Wafer Lot

= Year

WW = Work Week

G = Pb-Free Package

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present.

STYLE I:		STYLE 2:	
PIN 1.	MAIN TERMINAL 1	PIN 1.	CATHODE
2.	MAIN TERMINAL 2	2.	ANODE
3.	GATE	3.	GATE

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